

MD7000

CASE 654-07, STYLE 1

DUAL
GENERAL PURPOSE
TRANSISTOR

NPN SILICON

Refer to MD2218 for graphs.

MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Collector-Emitter Voltage	V_{CEO}	30	Vdc
Collector-Base Voltage	V_{CBO}	50	Vdc
Emitter-Base Voltage	V_{EBO}	5.0	Vdc
Collector Current — Continuous	I_C	500	mAdc
		One Die	Both Die
Total Device Dissipation @ $T_A = 25^\circ\text{C}$ Derate above 25°C	P_D	575	625
		3.29	3.57
Total Device Dissipation @ $T_C = 25^\circ\text{C}$ Derate above 25°C	P_D	1.8	2.5
		10.3	14.3
Operating and Storage Junction Temperature Range	T_J, T_{stg}	-65 to +200	$^\circ\text{C}$

THERMAL CHARACTERISTICS

Characteristic	Symbol	One Die	Both Die	Unit
Thermal Resistance, Junction to Case	$R_{\theta JC}$	97	70	$^\circ\text{C/W}$
Thermal Resistance, Junction to Ambient	$R_{\theta JA}(1)$	304	280	$^\circ\text{C/W}$
		Junction to Ambient	Junction to Case	
Coupling Factor		84	44	%

(1) $R_{\theta JA}$ is measured with the device soldered into a typical printed circuit board.

ELECTRICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$ unless otherwise noted.)

Characteristic	Symbol	Min	Typ	Max	Unit
OFF CHARACTERISTICS					
Collector-Emitter Breakdown Voltage(2) ($I_C = 10 \text{ mAdc}, I_E = 0$)	$V_{(BR)CEO}$	30	—	—	Vdc
Collector-Base Breakdown Voltage ($I_C = 10 \mu\text{Adc}, I_E = 0$)	$V_{(BR)CBO}$	50	—	—	Vdc
Emitter-Base Breakdown Voltage ($I_E = 10 \mu\text{Adc}, I_C = 0$)	$V_{(BR)EBO}$	5.0	—	—	Vdc
Collector Cutoff Current ($V_{CB} = 40 \text{ Vdc}, I_E = 0$)	I_{CBO}	—	—	100	nAdc
ON CHARACTERISTICS					
DC Current Gain(2) ($I_C = 1.0 \text{ mAdc}, V_{CE} = 10 \text{ Vdc}$) ($I_C = 150 \text{ mAdc}, V_{CE} = 10 \text{ Vdc}$) ($I_C = 300 \text{ mAdc}, V_{CE} = 10 \text{ Vdc}$)	h_{FE}	40 70 30	60 80 50	— — —	—
Collector-Emitter Saturation Voltage ($I_C = 150 \text{ mAdc}, I_B = 15 \text{ mAdc}$)	$V_{CE(sat)}$	—	0.2	0.4	Vdc
Base-Emitter Saturation Voltage ($I_C = 150 \text{ mAdc}, I_B = 15 \text{ mAdc}$)	$V_{BE(sat)}$	—	0.95	1.3	Vdc
SMALL-SIGNAL CHARACTERISTICS					
Current-Gain — Bandwidth Product ($I_C = 20 \text{ mAdc}, V_{CE} = 20 \text{ Vdc}, f = 100 \text{ MHz}$)	f_T	200	250	—	MHz
Output Capacitance ($V_{CB} = 10 \text{ Vdc}, I_E = 0, f = 100 \text{ kHz}$)	C_{obo}	—	3.5	8.0	pF
Input Capacitance ($V_{EB} = 2.0 \text{ Vdc}, I_C = 0, f = 100 \text{ kHz}$)	C_{ibo}	—	15	30	pF

(2) Pulse Test: Pulse Width $\leq 300 \mu\text{s}$, Duty Cycle $\leq 2.0\%$.